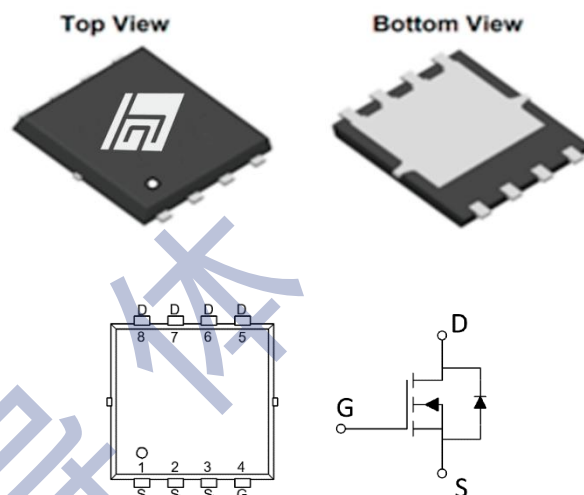




40V_{DS}/±20V_{GS} N-Channel EpicSGT MOSFET

Features

- V_{DS}=40V, I_D=69A
- R_{DS(ON)}= 3.9mΩ (TYP.) V_{GS}=10V, I_D=20A
- R_{DS(ON)}=5mΩ (TYP.) V_{GS}=4.5V, I_D=20A
- Reliable and Rugged
- Avalanche Rated
- Low On-Resistance
- High Current Capability
- Halogen and Antimony Free, RoHS compliant

PDFN5060

Applications

- Load Switch
- Power management in portable/desktop PCs
- DC/DC conversion

Ordering Information

Orderable Device	Package	Marking information	Package Qty.
AER4051AE	PDFN5060	AER4051AE ywwFxxx	5000pcs/Reel

Absolute Maximum Ratings (T_a=25°C, unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V _{DS}	40	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current (T _C =25°C)	I _D	69	A
Continuous Drain Current (T _C =100°C)		50	A
Pulsed Drain Current	I _{DM}	200	A
Avalanche Current (L=0.1mH)	I _{AS}	40	A
Single Pulsed Avalanche Energy	E _{AS}	80	mJ
Maximum Power Dissipation (T _C =25°C)	P _D	48	W
Maximum Power Dissipation (T _C =100°C)		20	W
Operating, Storage Temperature Range	T _J , T _{STG}	-55~150	°C



Thermal Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal Resistance,Junction-to-Case	$R_{\theta JC}$	-	2.6	-	$^{\circ}\text{C}/\text{W}$
Thermal Resistance,Junction-to-Ambient	$R_{\theta JA}$	-	54	-	$^{\circ}\text{C}/\text{W}$

Electrical Characteristics

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	40	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=40V, V_{GS}=0V$	-	-	1	μA
Gate -Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	1.0	1.5	2.0	V
Drain-Source On-stage Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=20A$	-	3.9	5.2	m Ω
		$V_{GS}=4.5V, I_D=20A$	-	5	6.5	

Dynamic Characteristics

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Input capacitance	C_{iss}	$V_{DS}=20V$	-	1087	-	pF
Output capacitance	C_{oss}	$V_{GS}=0V$	-	314	-	
Reverse transfer capacitance	C_{rss}	$f=1\text{MHz}$	-	19	-	
Gate Resistance	R_g	$f=1\text{MHz}$	-	1.1	-	Ω
Total Gate Charge	Q_g	$V_{DS}=20V$	-	21	-	nC
Gate Source Charge	Q_{gs}	$V_{GS}=10V$	-	4.3	-	
Gate Drain Charge	Q_{gd}	$I_D=20A$	-	4	-	
Turn-on delay Time	$t_{d(on)}$	$V_{GS}=10V$	-	4.7	-	ns
Rise time	t_r	$V_{DS}=20V$	-	41.5	-	
Turn-off delay Time	$t_{d(off)}$	$I_D=20A$	-	22	-	
Fall time	t_f	$R_G=3\Omega$	-	8	-	

Reverse Diode Characteristics

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Body Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_{SD}=1A$	-	0.7	1	V
Reverse Recovery Time	t_{rr}	$V_{GS}=0V, I_{SD}=20A$	-	16	-	ns
Reverse Recovery Charge	Q_{rr}	$dI/dt=100A/\mu s$	-	4	-	nC



Electrical Characteristics Diagrams

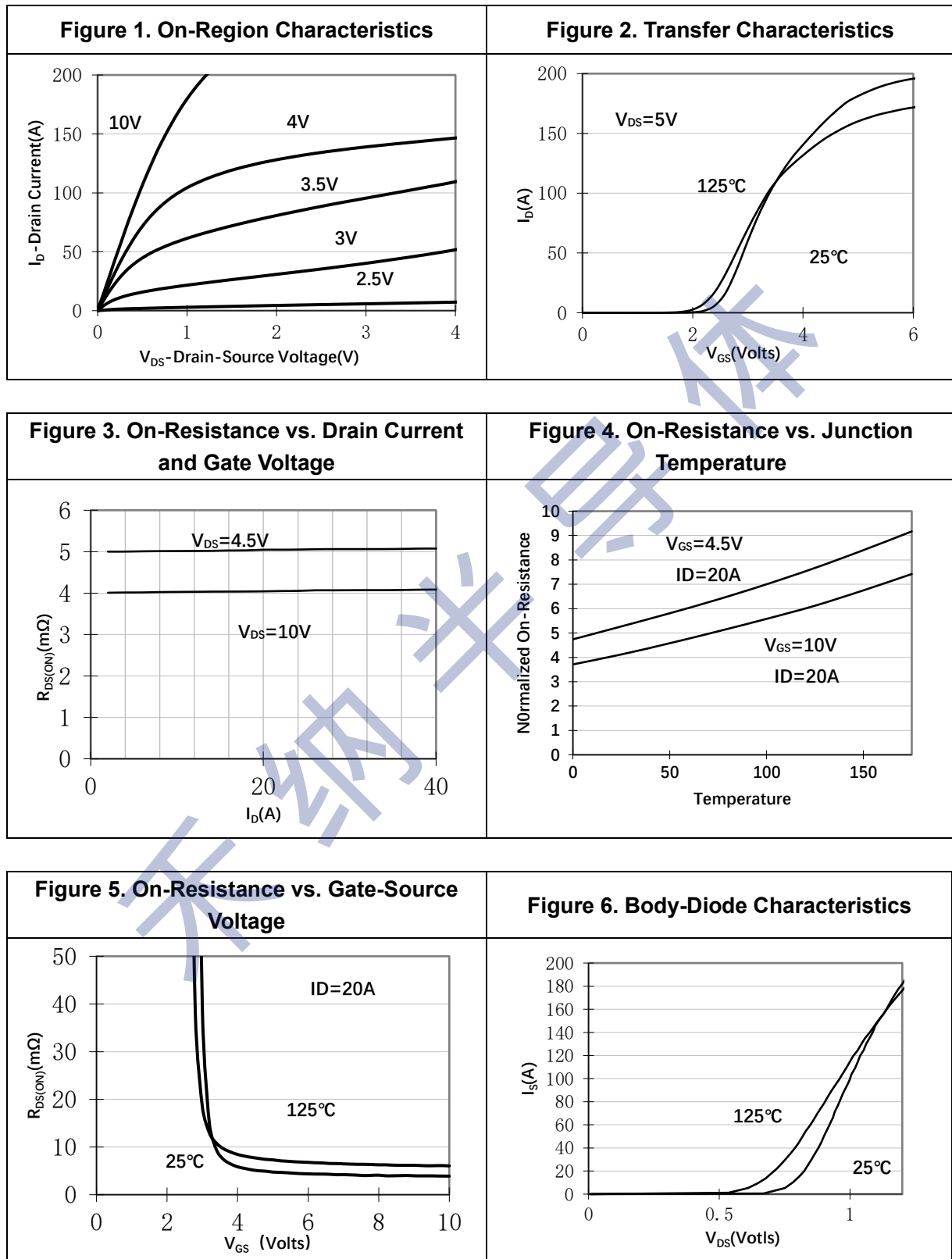




Figure 7. Gate-Charge Characteristics

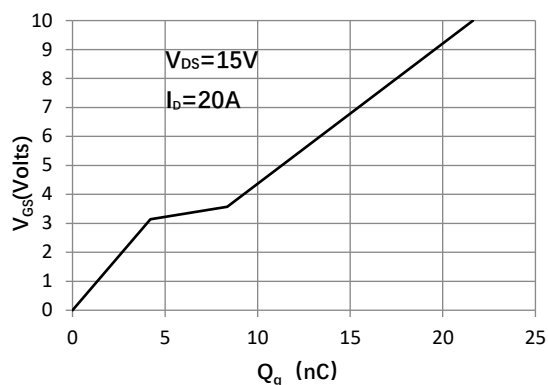


Figure 8. Capacitance Characteristics

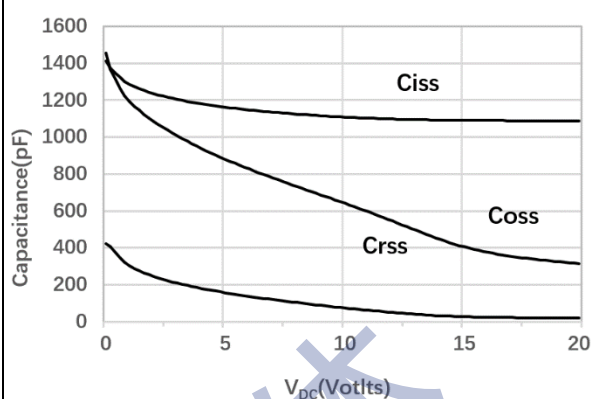


Figure 9. Maximum Forward Biased Safe Operating Area

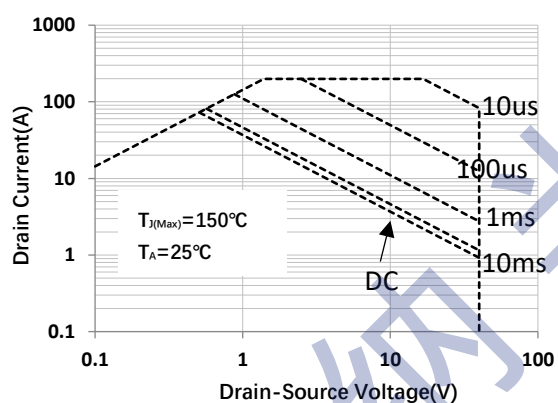


Figure 10. Single Pulse Power Rating Junction-to-Ambient

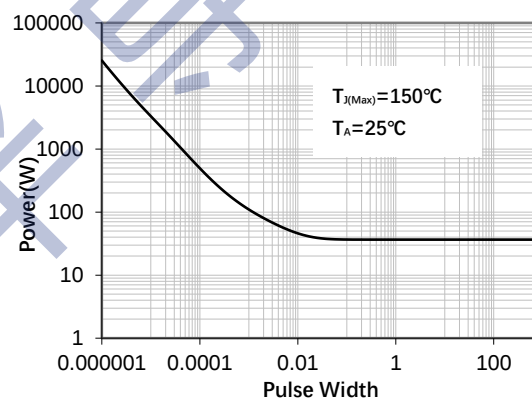
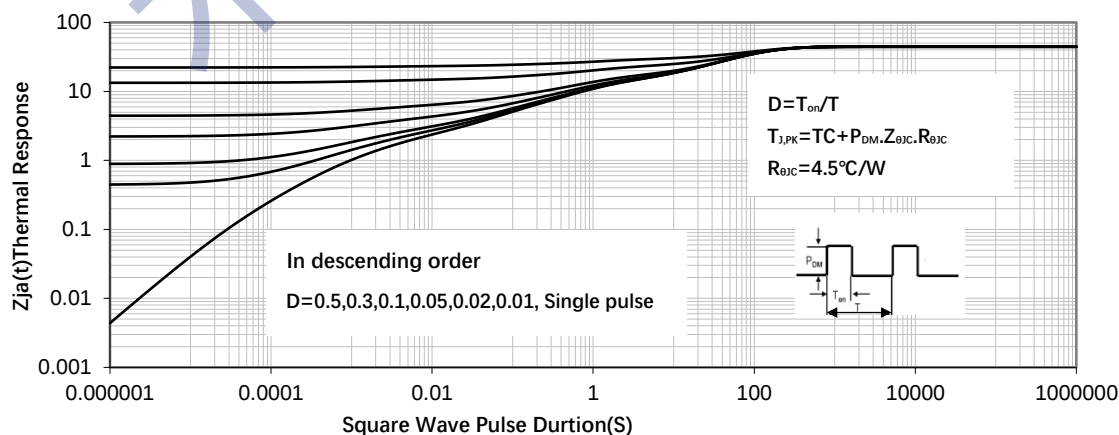


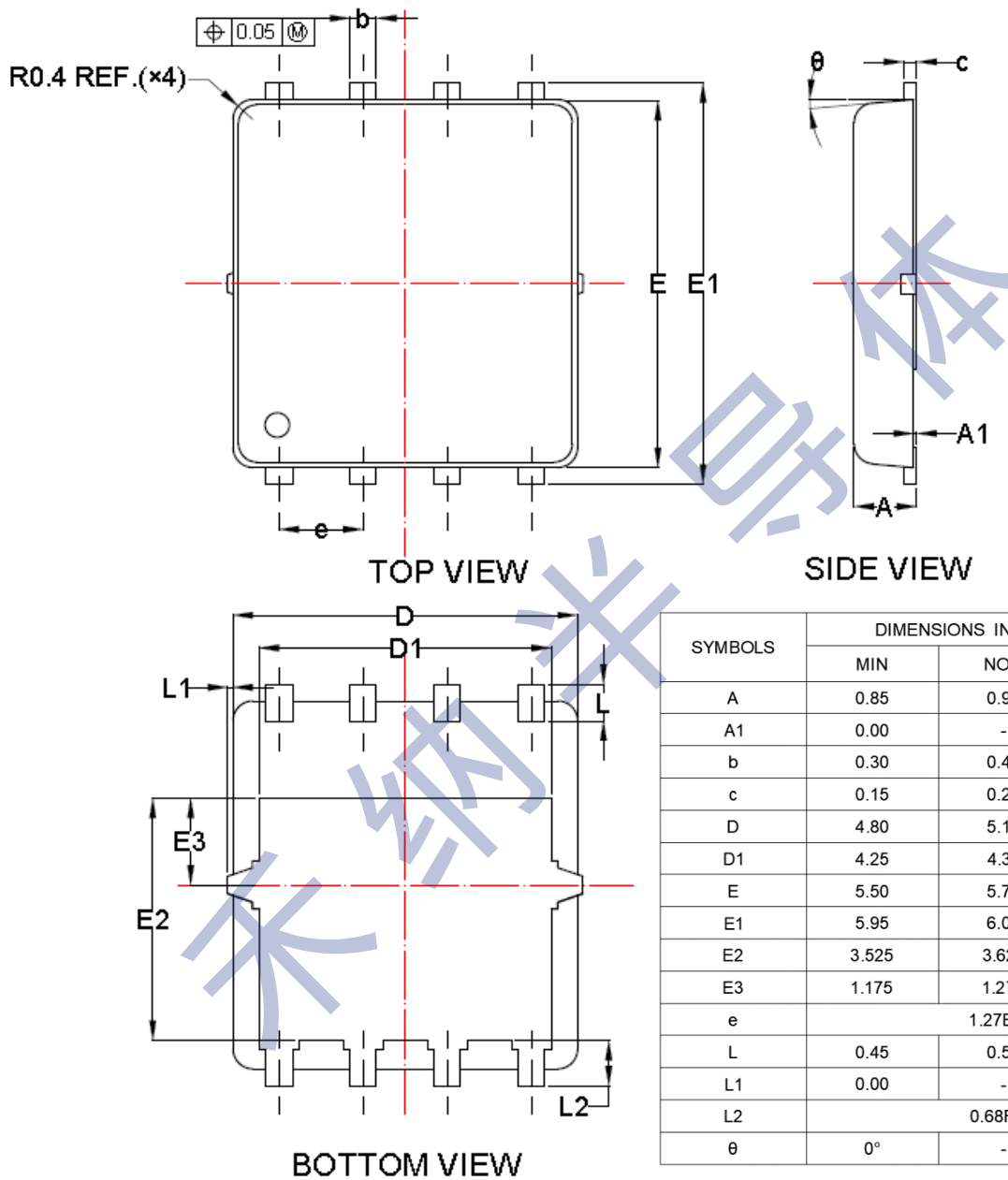
Figure 11. Normalized Maximum Transient Thermal Impedance





Physical Dimensions

PDFN5060



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